



# STP12NB30 STP12NB30FP

N-CHANNEL 300V - 0.34Ω - 12A TO-220/TO-220FP  
PowerMESH™ MOSFET

TYPE	V <sub>DSS</sub>	R <sub>D(on)</sub>	I <sub>D</sub>
STP12NB30	300 V	< 0.40 Ω	12A
STP12NB30FP	300 V	< 0.40 Ω	12A

- TYPICAL R<sub>D(on)</sub> = 0.34Ω
- EXCEPTIONAL dv/dt CAPABILITY
- 100% AVALANCHE TESTED
- VERY LOW INTRINSIC CAPACITANCES
- GATE CHARGE MINIMIZED

## DESCRIPTION

Using the latest high voltage MESH OVERLAY™ process, STMicroelectronics has designed an advanced family of power MOSFETs with outstanding performances. The new patent pending strip layout coupled with the Company's proprietary edge termination structure, gives the lowest R<sub>D(on)</sub> per area, exceptional avalanche and dv/dt capabilities and unrivalled gate charge and switching characteristics.

## APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- UNINTERRUPTIBLE POWER SUPPLY (UPS)
- DC-DC & DC-AC CONVERTERS FOR TELECOM, INDUSTRIAL AND CONSUMER ENVIRONMENT

## ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value		Unit
		STP12NB30	STP12NB30FP	
V <sub>DS</sub>	Drain-source Voltage (V <sub>GS</sub> = 0)	300		V
V <sub>DGR</sub>	Drain-gate Voltage (R <sub>GS</sub> = 20 kΩ)	300		V
V <sub>GS</sub>	Gate- source Voltage	± 30		V
I <sub>D</sub>	Drain Current (continuos) at T <sub>C</sub> = 25°C	12	12 (*)	A
I <sub>D</sub>	Drain Current (continuos) at T <sub>C</sub> = 100°C	7.5	7.5 (*)	A
I <sub>DM</sub> (I <sub>)</sub>	Drain Current (pulsed)	48	48 (*)	A
P <sub>TOT</sub>	Total Dissipation at T <sub>C</sub> = 25°C	125	35	W
	Derating Factor	1	0.28	W/°C
dv/dt (1)	Peak Diode Recovery voltage slope	5.5		V/ns
V <sub>ISO</sub>	Insulation Winthstand Voltage (DC)	--	2500	V
T <sub>stg</sub>	Storage Temperature		−65 to 150	°C
T <sub>j</sub>	Max. Operating Junction Temperature			

(●) Pulse width limited by safe operating area

(1) I<sub>SD</sub>≤ 60A, di/dt≤400 A/μs, V<sub>DD</sub>≤ 24V, T<sub>j</sub>≤T<sub>jMAX</sub>

(\*)Limited only by maximum temperature allowed

## STP12NB30 - STP12NB30FP

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### THERMAL DATA

		TO-220	TO-220FP	
Rthj-case	Thermal Resistance Junction-case	Max	1	3.57 °C/W
Rthj-amb T <sub>I</sub>	Thermal Resistance Junction-ambient Maximum Lead Temperature For Soldering Purpose	Max	62.5 300	°C/W °C

### AVALANCHE CHARACTERISTICS

Symbol	Parameter	Max Value	Unit
I <sub>AR</sub>	Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T <sub>j</sub> max)	12	A
E <sub>AS</sub>	Single Pulse Avalanche Energy (starting T <sub>j</sub> = 25 °C, I <sub>D</sub> = I <sub>AR</sub> , V <sub>DD</sub> = 30 V)	250	mJ

### ELECTRICAL CHARACTERISTICS (TCASE = 25 °C UNLESS OTHERWISE SPECIFIED)

OFF

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0	300			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = Max Rating V <sub>DS</sub> = Max Rating, T <sub>C</sub> = 125 °C			1 10	μA μA
I <sub>GSS</sub>	Gate-body Leakage Current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20V			±100	nA

### ON (1)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	3	4	5	V
R <sub>D(on)</sub>	Static Drain-source On Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 6 A		0.34	0.4	Ω

### DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
g <sub>fs</sub> (1)	Forward Transconductance	V <sub>DS</sub> > I <sub>D(on)</sub> × R <sub>D(on)max</sub> , I <sub>D</sub> = 6A		7.2		S
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25V, f = 1 MHz, V <sub>GS</sub> = 0		1050		pF
C <sub>oss</sub>	Output Capacitance			200		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			25		pF

**ELECTRICAL CHARACTERISTICS (CONTINUED)****SWITCHING ON**

<b>Symbol</b>	<b>Parameter</b>	<b>Test Conditions</b>	<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	<b>Unit</b>
$t_{d(on)}$	Turn-on Delay Time	$V_{DD} = 150\text{ V}$ , $I_D = 6\text{ A}$ $R_G = 4.7\Omega$ $V_{GS} = 10\text{V}$ (see test circuit, Figure 3)		18		ns
$t_r$	Rise Time			8		ns
$Q_g$ $Q_{gs}$ $Q_{gd}$	Total Gate Charge Gate-Source Charge Gate-Drain Charge	$V_{DD} = 240\text{V}$ , $I_D = 12\text{A}$ , $V_{GS} = 10\text{V}$		29 11 12	40	nC nC nC

**SWITCHING OFF**

<b>Symbol</b>	<b>Parameter</b>	<b>Test Conditions</b>	<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	<b>Unit</b>
$t_{d(off)}$	Off-voltage Rise Time	$V_{clamp} = 240\text{V}$ , $I_D = 12\text{ A}$		10		ns
$t_f$	Fall Time	$R_G = 4.7\Omega$ , $V_{GS} = 10\text{V}$		10		ns
$t_c$	Cross-over Time	(see test circuit, Figure 3)		18		ns

**SOURCE DRAIN DIODE**

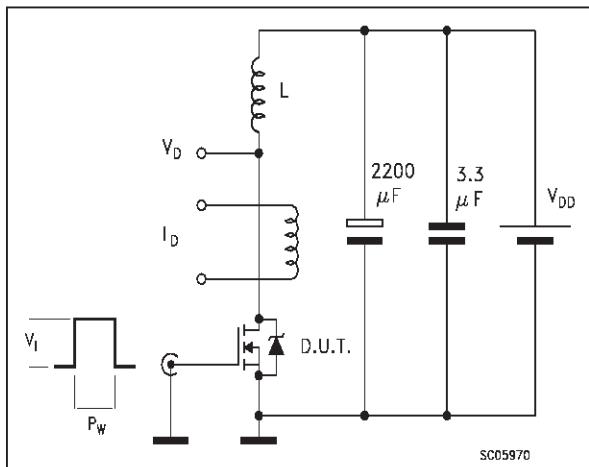
<b>Symbol</b>	<b>Parameter</b>	<b>Test Conditions</b>	<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	<b>Unit</b>
$I_{SD}$	Source-drain Current				12	A
$I_{SDM(2)}$	Source-drain Current (pulsed)				48	A
$V_{SD}(1)$	Forward On Voltage	$I_{SD} = 12\text{ A}$ , $V_{GS} = 0$			1.5	V
$t_{rr}$ $Q_{rr}$ $I_{RRM}$	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$I_{SD} = 12\text{ A}$ , $di/dt = 100\text{A}/\mu\text{s}$ , $V_{DD} = 100\text{V}$ , $T_j = 150^\circ\text{C}$ (see test circuit, Figure 5)		250 2 16		ns $\mu\text{C}$ A

Note: 1. Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5 %.

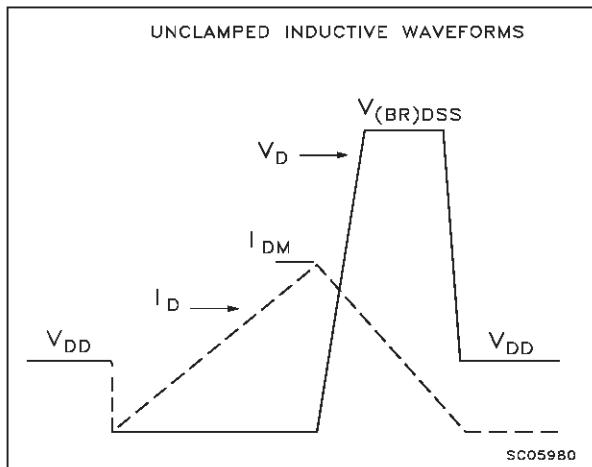
2. Pulse width limited by safe operating area.

## STP12NB30 - STP12NB30FP

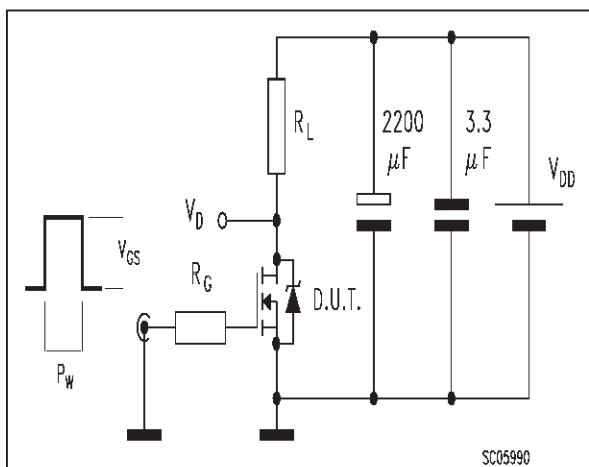
**Fig. 1:** Unclamped Inductive Load Test Circuit



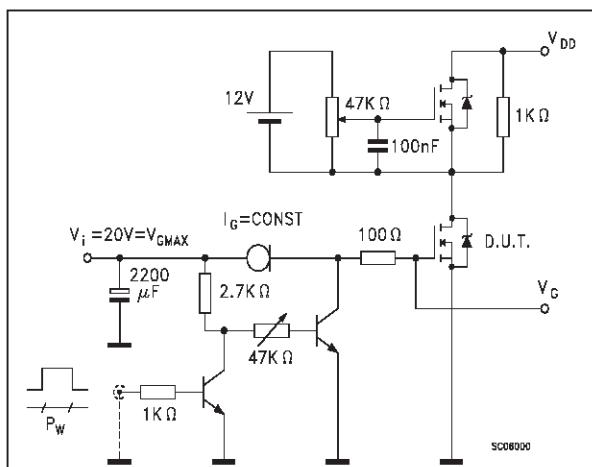
**Fig. 2:** Unclamped Inductive Waveform



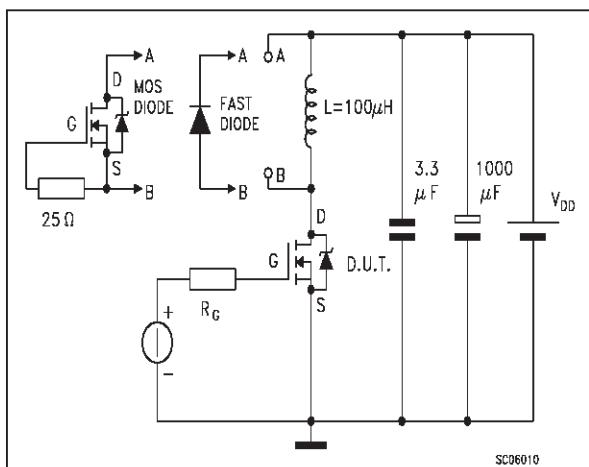
**Fig. 3:** Switching Times Test Circuit For Resistive Load



**Fig. 4:** Gate Charge test Circuit

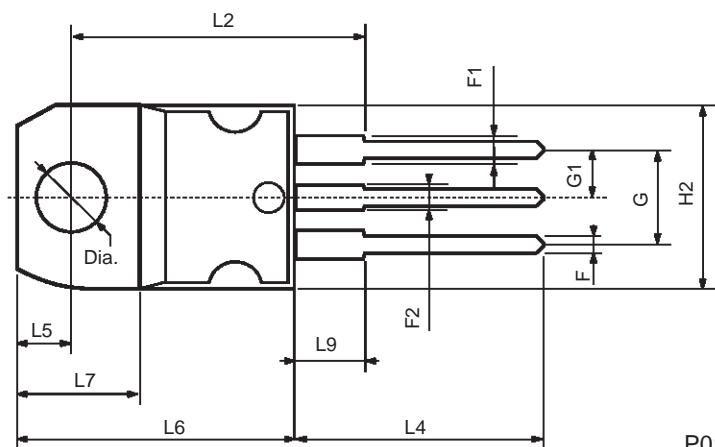
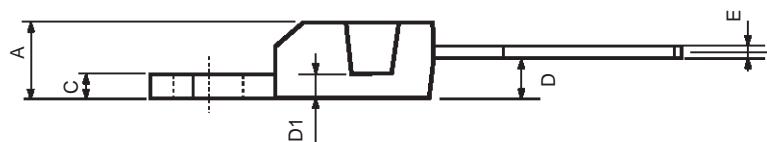


**Fig. 5:** Test Circuit For Inductive Load Switching And Diode Recovery Times



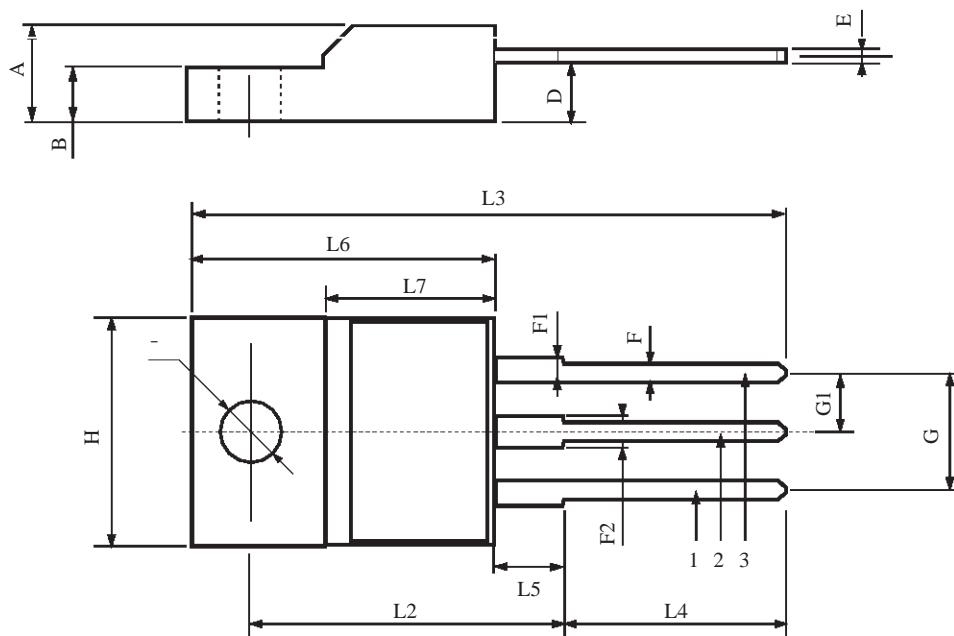
## TO-220 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	4.40		4.60	0.173		0.181
C	1.23		1.32	0.048		0.051
D	2.40		2.72	0.094		0.107
D1		1.27			0.050	
E	0.49		0.70	0.019		0.027
F	0.61		0.88	0.024		0.034
F1	1.14		1.70	0.044		0.067
F2	1.14		1.70	0.044		0.067
G	4.95		5.15	0.194		0.203
G1	2.4		2.7	0.094		0.106
H2	10.0		10.40	0.393		0.409
L2		16.4			0.645	
L4	13.0		14.0	0.511		0.551
L5	2.65		2.95	0.104		0.116
L6	15.25		15.75	0.600		0.620
L7	6.2		6.6	0.244		0.260
L9	3.5		3.93	0.137		0.154
DIA.	3.75		3.85	0.147		0.151



**TO-220FP MECHANICAL DATA**

DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	4.4		4.6	0.173		0.181
B	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
E	0.45		0.7	0.017		0.027
F	0.75		1	0.030		0.039
F1	1.15		1.5	0.045		0.067
F2	1.15		1.5	0.045		0.067
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
H	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	0.385		0.417
L5	2.9		3.6	0.114		0.141
L6	15.9		16.4	0.626		0.645
L7	9		9.3	0.354		0.366
Ø	3		3.2	0.118		0.126



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